WEST Refine Search Page 1 of 2

Refine Search

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Term	Documents
(7 AND 23).PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD.	44
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DB=P	GPB, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR=YES; OP=OR		
<u>L27</u>	L23 and 17	44	<u>L27</u>
<u>L26</u>	L23 and 16	4	<u>L26</u>
<u>L25</u>	L23 and 15	280	<u>L25</u>
<u>L24</u>	L23 and 14	166	<u>L24</u>
<u>L23</u>	L22 and 11	1269	<u>L23</u>
<u>L22</u>	(conflict\$3 or contention\$1 or contend\$3 or hazard\$5) near15 read\$3 near15 writ\$4	2422	<u>L22</u>
<u>L21</u>	L17 and 17	0	<u>L21</u>
<u>L20</u>	L17 and 16	0	<u>L20</u>
<u>L19</u>	L17 and 15	4	<u>L19</u>
<u>L18</u>	L17 and 14	7	<u>L18</u>
<u>L17</u>	L16 and read\$3 near15 writ\$3 near15 interlock\$4	24	<u>L17</u>

<u>L16</u>	(recover\$7 or resum\$6) near8 address\$3	7088	<u>L16</u>
	· ·	7000	<u>1710</u>
DB=P	PGPB,USPT; PLUR=YES; OP=OR		
<u>L15</u>	12 and 17	4	<u>L15</u>
<u>L14</u>	12 and 16	1	<u>L14</u>
<u>L13</u>	12 and 15	30	<u>L13</u>
<u>L12</u>	12 and 14	32	<u>L12</u>
<u>L11</u>	13 and 17	. 2	<u>L11</u>
<u>L10</u>	13 and 16	0	<u>L10</u>
<u>L9</u>	13 and 15	20	<u>L9</u>
<u>L8</u>	13 and 14	. 19	<u>L8</u>
<u>L7</u>	(712/216,217)[CCLS]	823	<u>L7</u>
<u>L6</u>	(711/155)[CCLS]	182	<u>L6</u>
<u>L5</u>	(711/140-221)![CCLS]	17320	<u>L5</u>
<u>L4</u>	(712/2-300)[CCLS]	10993	<u>L4</u>
DB=F	PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR		•
<u>L3</u>	L2 and (recover\$7 or resum\$6)	95	<u>L3</u>
<u>L2</u>	L1 and read\$3 near15 writ\$3 near15 interlock\$4	191	<u>L2</u>
<u>L1</u>	(writ\$5 or read\$6) near5 (queu\$3 or buffer\$4)	96956	<u>L1</u>

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			AbstractPlus Full Text: PDF(356 KB) เลอส Cพร	
			2. Relating buffer-oriented microarchitecture validation to hig Utamaphethai, N.; Blanton, R.D.; Shen, J.P.;	gh-level pipeline functionality

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